Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10541906	FINCH ET AL.
Examiner	Art Unit
l o Hion	3663

SEARCHED				
Class	Subclass	Date	Examiner	
Inventor's		12/20/2006	Hien Le	
Name Search		·		
Plus Search		12/20/2006	Hien Le	
NPL Search	·	12/20/2006	Hien Le	
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SEARCH NOTES				
Search Notes	Date	Examine		

•	INTERFERENCE SEARCH		
Class	Subclass	Date	Examine

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